

UTC UNISONIC TECHNOLOGIES CO., LTD

15NM90-Q **Preliminary Power MOSFET**

15A, 900V N-CHANNEL SUPER-JUNCTION MOSFET

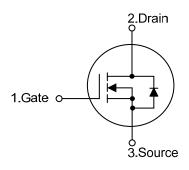
DESCRIPTION

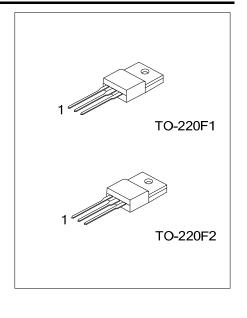
The UTC 15NM90-Q is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at AC-DC converters for power applications.

FEATURES

- * $R_{DS(ON)} \le 0.5 \Omega @ V_{GS} = 10V, I_D = 7.5A$
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

SYMBOL

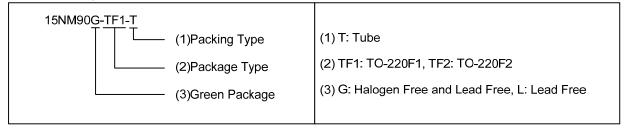




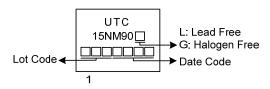
ORDERING INFORMATION

Ordering Number		Deeleene	Pin Assignment			Daakina	
Lead Free	Halogen Free	Package	1	2	3	Packing	
15NM90L-TF1-T	15NM90G-TF1-T	TO-220F1	G	D	S	Tube	
15NM90L-TF2-T	15NM90G-TF2-T	TO-220F2	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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■ **ABSOLUTE MAXIMUM RATINGS** (T_C=25°C, unless otherwise specified)

PARAMETER			SYMBOL	RATINGS	UNIT	
Drain-Source Voltage			V_{DSS}	900	V	
Gate-Source Voltage			V _{GSS}	±30	V	
Drain Current	Cantinuaus	T _C =25°C	I _D	15	Α	
	Continuous	T _C =100°C		9.7	Α	
	Pulsed (Note	Pulsed (Note 2)		45	Α	
Avalanche Energy	Single Pulsed	Single Pulsed (Note 3)		450	mJ	
Peak Diode Recovery	ak Diode Recovery dv/dt (Note 4)		dv/dt	1.1	V/ns	
Power Dissipation		P _D	28	W		
Junction Temperature		TJ	+150	°C		
Storage Temperature		T _{STG}	-55 ~ +150	°C		

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 100mH, I_{AS} = 3.0A, V_{DD} = 90V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 4. $I_{SD} \leq 15 A$, di/dt $\leq 200 A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting T_J = 25°C

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θЈΑ	62.5	°C/W	
Junction to Case	θјс	4.46	°C/W	

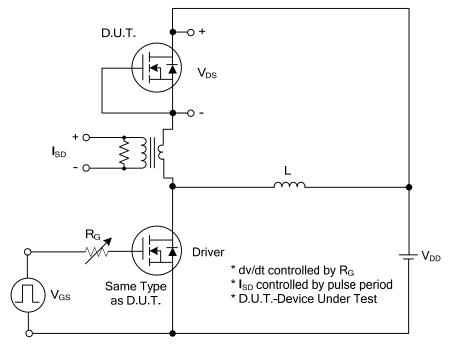
■ **ELECTRICAL CHARACTERISTICS** (T_J=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT	
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	900			V	
Drain-Source Leakage Current	I _{DSS}	V _{DS} =900V, V _{GS} =0V			10	μΑ	
Gate-Source Leakage Current	I_{GSS}	V_{GS} =±30V, V_{DS} =0V			±100	nA	
ON CHARACTERISTICS							
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.5		4.5	V	
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =7.5A			0.5	Ω	
DYNAMIC CHARACTERISTICS							
Input Capacitance	C _{ISS}			1315		pF	
Output Capacitance	Coss	V_{GS} =0V, V_{DS} =50V, f=1MHz		180		pF	
Reverse Transfer Capacitance	C _{RSS}			2.5		pF	
SWITCHING CHARACTERISTICS							
Total Gate Charge	Q_G	\/ -720\/ \/ -10\/ -15A		59		nC	
Gate-Source Charge	Q_GS	V _{DS} =720V, V _{GS} =10V, I _D =15A (Note 1, 2)		18		nC	
Gate-Drain Charge	Q_{DD}			21		nC	
Turn-On Delay Time	t _{D(ON)}			18		ns	
Turn-On Rise Time	t _R	V _{DD} =100V, V _{GS} =10V, I _D =15A,		28		ns	
Turn-Off Delay Time	t _{D(OFF)}	R _G =25Ω (Note 1, 2)		156		ns	
Turn-Off Fall Time	t⊧			56		ns	
SOURCE- DRAIN DIODE RATINGS AND C	HARACTERI	STICS					
Maximum Continuous Drain-Source Diode	ls				15	Α	
Forward Current	rward Current				13	^	
Maximum Pulsed Drain-Source Diode	I _{SM}				45	Α	
Forward Current	ISIVI				70	^	
Drain-Source Diode Forward Voltage	V _{SD}	Is=15A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time	t _{rr}	Is=15A, V _{GS} =0V,		388		nS	
Body Diode Reverse Recovery Charge	Qrr	dl _F /dt=100A/μs		11.4		μC	

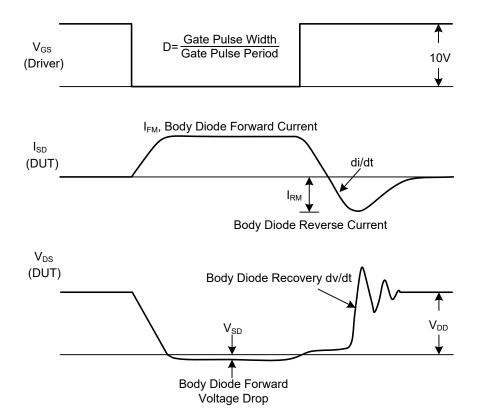
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle≤2%.

^{2.} Essentially independent of operating temperature.

TEST CIRCUITS AND WAVEFORMS

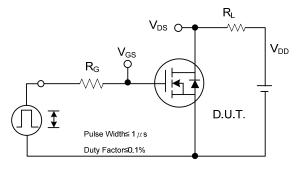


Peak Diode Recovery dv/dt Test Circuit

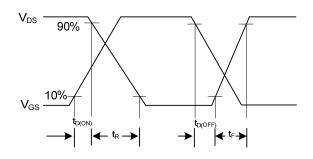


Peak Diode Recovery dv/dt Waveforms

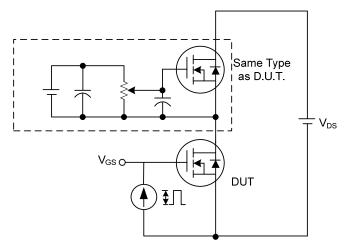
■ TEST CIRCUITS AND WAVEFORMS



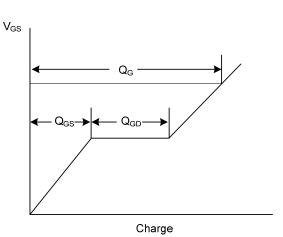
Switching Test Circuit



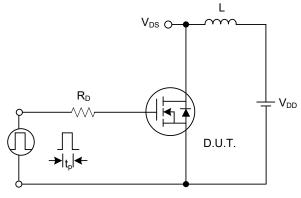
Switching Waveforms



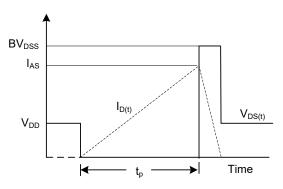
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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